



Reliability test report

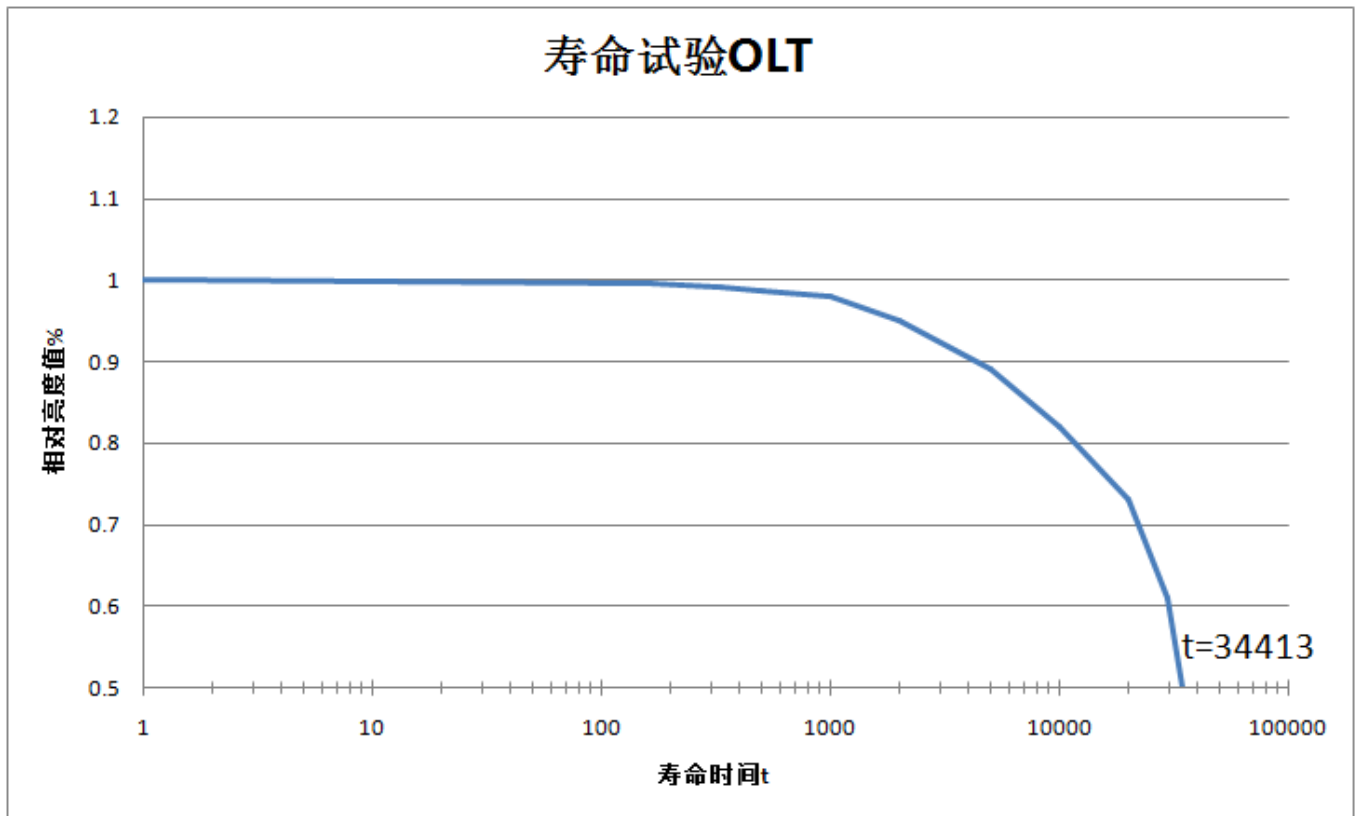
LT P/N LT3014WH-E-Q

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Iv

Test Item	Iv Test time and brightness relation rate.					Fail No.	Conclusion	Remark
	0hr	168hrs	336hrs	500hrs	1000hrs			
(OLT)	1	1.0062	0.9931	0.9882	0.9830	0	Pass	(Test Condition) : IF =20mA; 1000Hrs

Data Set ----25°C , 80mA	
Part Number:	LT3014WH-E-Q
Number of Units:	20pcs
Actual Case Temperature(TS):	TS=40.9°C
Actual Ambient Temperature(TA):	TA=25.4°C
Life Test Drive Current :	IF=80mA



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LED 50%MD 46-BDGTLED11.04 T1 0 DED40.50.22 T016
MTBF

$$R(\%)=[e^{-\lambda t}]$$

VES

t

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LED